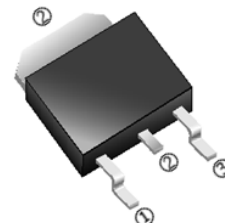


RoHS Compliant Product
A suffix of "-C" specifies halogen free

DESCRIPTION

SSD40N10S-C use advanced SGT MOSFET technology to provide low $R_{DS(ON)}$, low gate charge, fast switching and excellent avalanche characteristics.

TO-252(D-Pack)



FEATURES

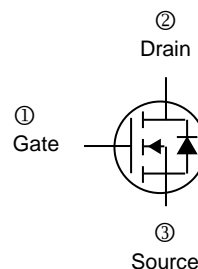
- Extremely Low Switching Loss
- Excellent Stability and Uniformity of Invertors

PACKAGE INFORMATION

Package	MPQ	Leader Size
TO-252	2.5K	13 inch

ORDER INFORMATION

Part Number	Type
SSD40N10S-C	Lead (Pb)-free and Halogen-free



ABSOLUTE MAXIMUM RATINGS ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	$T_C=25^{\circ}\text{C}$ I_D	40	A
Pulsed Drain Current ²	$T_C=25^{\circ}\text{C}$ I_{DM}	120	A
Power Dissipation ³	$T_C=25^{\circ}\text{C}$ P_D	72	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150	$^{\circ}\text{C}$
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	62	$^{\circ}\text{C/W}$
Thermal Resistance Junction-Case	$R_{\theta JC}$	1.74	

Notes:

1. Calculated continuous current based on maximum allowable junction temperature.
2. Repetitive rating : pulse width limited by max. junction temperature.
3. P_d is based on max. junction temperature, using junction-case thermal resistance.

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	100	-	-	V	$V_{GS}=0, I_D=250\mu\text{A}$
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	2.5	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$V_{DS}=100\text{V}, V_{GS}=0$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	-	-	20	m Ω	$V_{GS}=10\text{V}, I_D=8\text{A}$
		-	-	26		$V_{GS}=4.5\text{V}, I_D=6\text{A}$
Total Gate Charge	Q_g	-	19.8	-	nC	$V_{DS}=50\text{V}$ $V_{GS}=10\text{V}$ $I_D=8\text{A}$
Gate-Source Charge	Q_{gs}	-	2.4	-		
Gate-Drain Change	Q_{gd}	-	5.3	-		
Turn-on Delay Time	$T_{d(on)}$	-	17.8	-	nS	$V_{DS}=50\text{V}$ $V_{GS}=10\text{V}$ $I_D=10\text{A}$ $R_G=2.2\Omega$
Rise Time	T_r	-	3.9	-		
Turn-off Delay Time	$T_{d(off)}$	-	33.5	-		
Fall Time	T_f	-	3.2	-		
Input Capacitance	C_{iss}	-	1190.6	-	pF	$V_{DS}=50\text{V}$ $V_{GS}=0$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	194.6	-		
Reverse Transfer Capacitance	C_{rss}	-	4.1	-		
Source-Drain Diode						
Continuous Source Current	I_S	-	-	40	A	$V_G=V_D=0, \text{Force Current}$
Pulsed Source Current	I_{SM}	-	-	120		
Diode Forward Voltage	V_{SD}	-	-	1.3	V	$I_S=8\text{A}, V_{GS}=0$
Reverse Recovery Time	T_{rr}	-	50.2	-	nS	$I_S=8\text{A}, di/dt=100\text{A}/\mu\text{s}$
Reverse Recovery Charge	Q_{rr}	-	95.1	-	nC	

CHARACTERISTIC CURVES

Fig 1: Typ. Output Characteristics

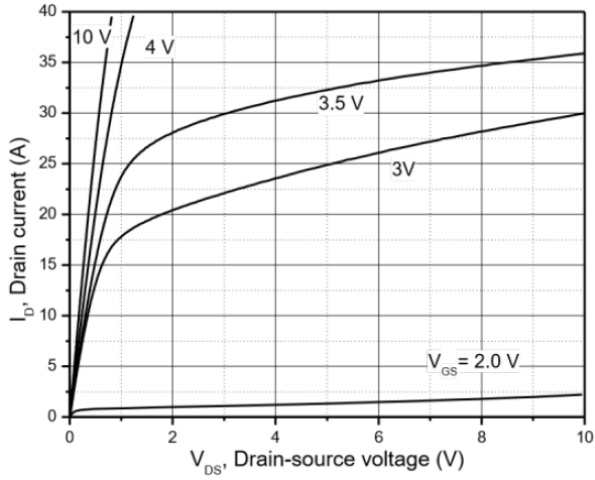


Fig 2: Typ. Transfer Characteristics

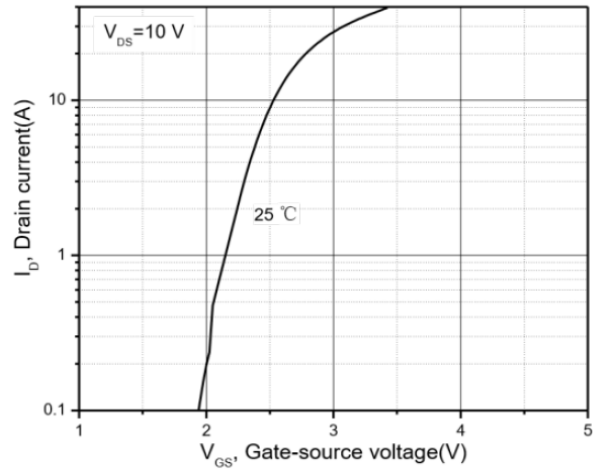


Fig 3: Typ. Capacitances

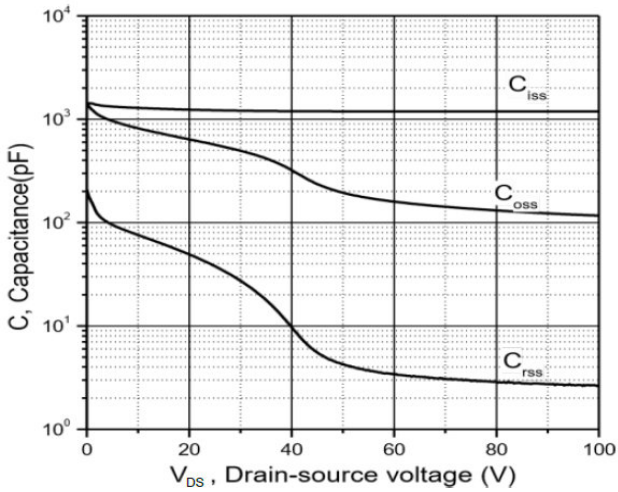


Fig 4: Typ. Gate Charge

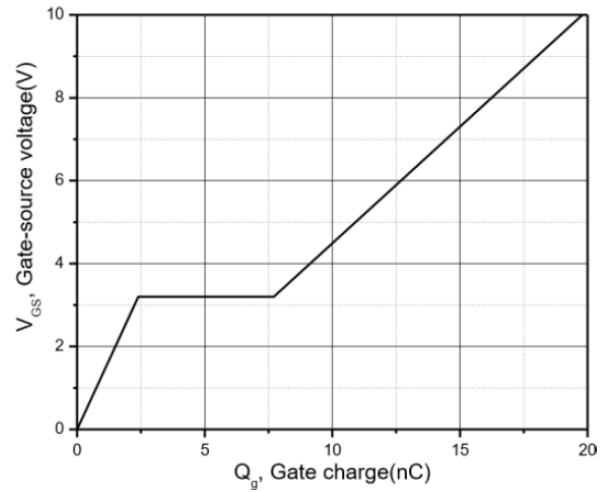


Fig 5: Drain-Source Breakdown Voltage

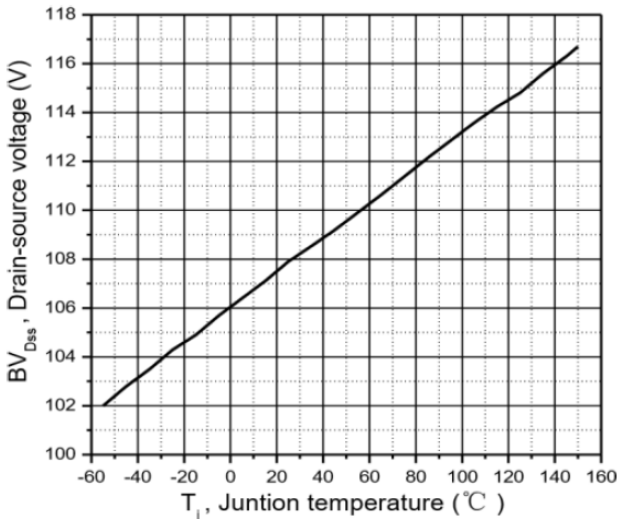
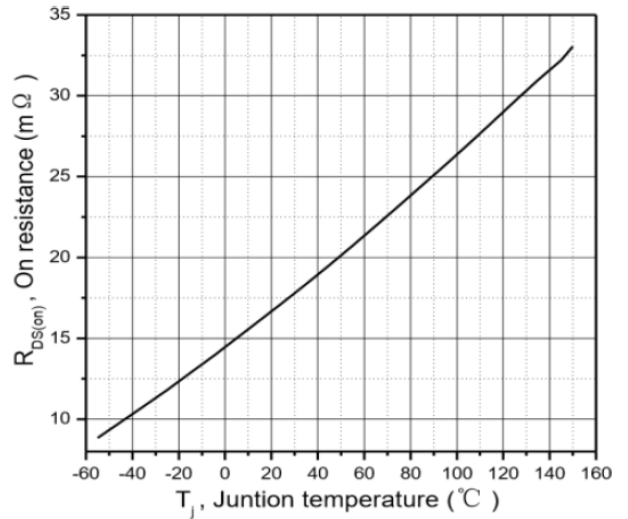


Fig 6: Drain-Source On-State Resistance



CHARACTERISTIC CURVES

Fig 7: Forward Characteristic of Body Diode

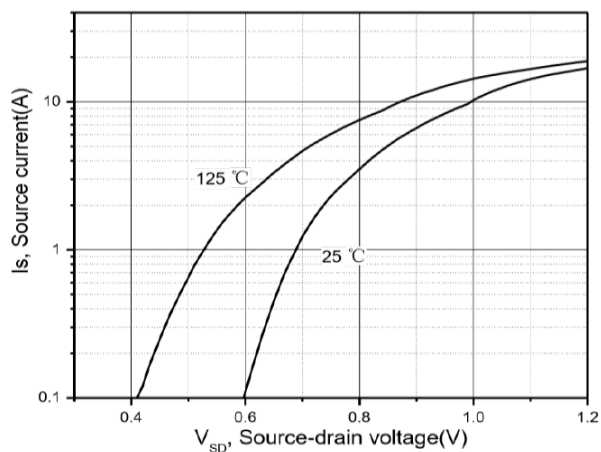


Fig 8: Drain-Source On-Resistance

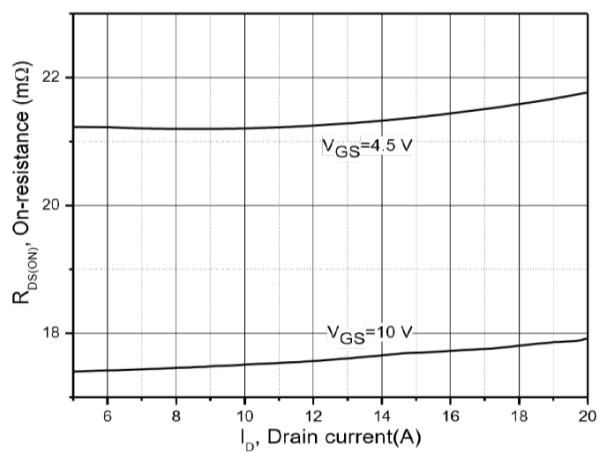
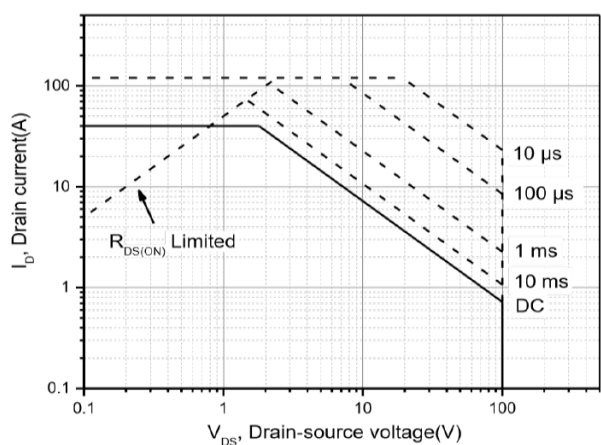
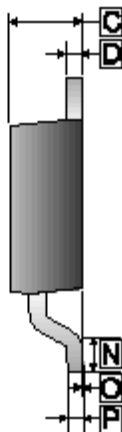
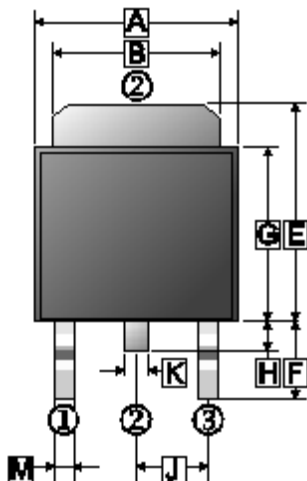


Fig 9: Safe Operation Area $T_C=25^\circ\text{C}$



PACKAGE OUTLINE DIMENSIONS

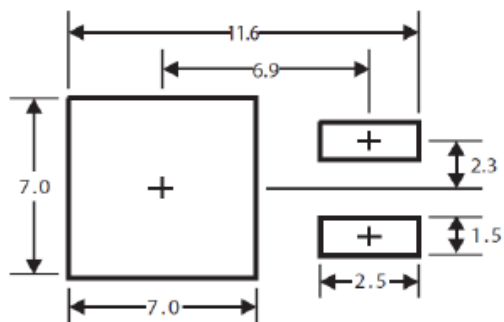
TO-252



REF.	Millimeter	
	Min.	Max.
A	6.30	6.90
B	4.95	5.53
C	2.10	2.50
D	0.35	0.90
E	6.00	7.70
F	2.90 REF.	
G	5.30	6.40
H	0.60	1.20
J	2.30 REF.	
K	0.89 REF.	
M	0.45	1.14
N	1.55 TYP.	
O	0	0.15
P	0.58 REF.	

MOUNTING PAD LAYOUT

TO-252



*Dimensions in millimeters